







SN54AC374, SN74AC374

SCAS543G - OCTOBER 1995 - REVISED FEBRUARY 2024

SNx4AC374 Octal D-Type Edge-Triggered Flip-Flops with 3-State Outputs

1 Features

- Operation of 2V to 6V V_{CC}
- Inputs accept voltages to 6V
- Max t_{pd} of 9.5ns at 5V
- 3-state noninverting outputs drive bus lines directly
- Full parallel access for loading

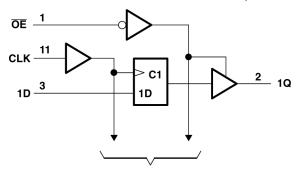
2 Description

These 8-bit flip-flops feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. The devices are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE(2)	BODY SIZE(3)
	DB (SSOP, 20)	7.2mm x 7.8mm	7.2mm x 5.30mm
	DW (SOIC, 20)	12.80mm x 10.3mm	12.80mm x 7.50mm
SNx4AC374	N (PDIP, 20)	24.33mm x 9.4mm	24.33mm x 6.35mm
	NS (SOP, 20)	12.6mm x 7.8mm	12.6mm x 5.3mm
	PW (TSSOP, 20)	6.50mm x 6.4mm	6.50mm x 4.40mm

- For more information, see Section 10.
- The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.



To Seven Other Channels Logic Diagram (Positive Logic)

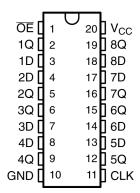


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3 Pin Configuration and Functions



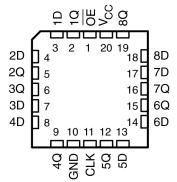


Figure 3-1. SN54AC374 J or W Package; SN74AC374 DB, DW, N, NS, or PW Package (Top View)

Figure 3-2. SN54AC374 FK Package (Top View)

Table 3-1. Pin Functions

F	PIN	TVDE	DESCRIPTION
NAME	NO.	TYPE	DESCRIPTION
ŌĒ	1	I	Enable pin
1Q	2	0	Output 1
1D	3	I	Input 1
2D	4	I	Input 2
2Q	5	0	Output 2
3Q	6	0	Output 3
3D	7	I	Input 3
4D	8	I	Input 4
4Q	9	0	Output 4
GND	10	_	Ground pin
CLK	11	I	Clock pin
5Q	12	0	Output 5
5D	13	I	Input 5
6D	14	I	Input 6
6Q	15	0	Output 6
7Q	16	0	Output 7
7D	17	I	Input 7
8D	18	I	Input 8
8Q	19	0	Output 8
V _{CC}	20	_	Power pin



4 Specifications

4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)¹

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
V _I ²	Input voltage range		-0.5	V _{CC} + 0.5	V
V _O ²	Output voltage range			V _{CC} + 0.5	V
I _{IK}	Input clamp current	(V _I < 0 or V _I > V _{CC)}		±20	mA
I _{OK}	Output clamp current	$(V_O < 0 \text{ or } V_O > V_{CC)}$		±20	mA
Io	Continuous output current	$(V_O = 0 \text{ to } V_{CC})$		±50	mA
	Continuous current through V _{CC} or GN	ID		±200	mA
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

4.2 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)¹

			SN54AC37	54AC374 SN74		N74AC374	
			MIN	MAX	MIN	MAX	UNIT
V _{CC}	Supply voltage		2	6	2	6	V
		V _{CC} = 3 V	2.1		2.1		
V _{IH}	High-level input voltage	V _{CC} = 4.5 V	3.15		3.15		V
		V _{CC} = 5.5 V	3.85		3.85		
		V _{CC} = 3 V		0.9		0.9	
V _{IL}	Low-level input voltage	V _{CC} = 4.5V		1.35		1.35	- I
		V _{CC} = 5.5 V		1.65		1.65	
VI	Input voltage		0	V _{CC}	0	V _{CC}	V
Vo	Output voltage		0	V _{CC}	0	V _{CC}	V
		V _{CC} = 3 V		-12		-12	
I _{OH}	High-level output current	V _{CC} = 4.5 V		-24		-24	mA
		V _{CC} = 5.5 V		-24		-24	
		V _{CC} = 3 V		12		12	
I _{OL}	Low-level output current	V _{CC} = 4.5 V		24		24	mA
		V _{CC} = 5.5 V		24		24	
Δt/Δν	Input transition rise or fall rate			8		8	ns/V
T _A	Operating free-air temperature		-55	125	-40	85	°C

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND for proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

Product Folder Links: SN54AC374 SN74AC374

⁽²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.



4.3 Thermal Information

			SN74AC374						
	THERMAL METRIC ⁽¹⁾		DW (SOIC)	N (PDIP)	NS (SO)	PW (TSSOP)	UNIT		
		20 PINS	20 PINS	20 PINS	20 PINS	20 PINS			
$R_{\theta JA}$	Junction-to-ambient thermal resistance	70	101.2	69	60	83	°C/W		

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

4.4 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST COMPLICANS		T	_ = 25°C	SN54A	C374	SN74A	C374	UNIT
PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP MAX	MIN	MAX	MIN	MAX	UNII
		3 V	2.9		2.9		2.9		
	I _{OH} = -50μA	4.5 V	4.4		4.4		4.4		
\ <u>\</u>		5.5 V	5.4		5.4		5.4		v
V _{OH}	I _{OH} = −12 mA	3 V	2.56		2.4		2.46		·
	_ = -24 mΛ	4.5 V	3.86		3.7		3.76		
	I _{OH} = −24 mA	5.5 V	4.86		4.7		4.76		
		3 V		0.1		0.1		0.1	
	I _{OL} = 50μA	4.5 V		0.1		0.1		0.1	
\ <u>\</u>		5.5 V		0.1		0.1		0.1	v
V _{OL}	I _{OL} = 12 mA	3 V		0.36		0.5		0.44	·
	1 - 24 mA	4.5 V		0.36		0.5		0.44	
	I _{OL} = 24 mA	5.5 V		0.36		0.5		0.44	
II	V _I = V _{CC} or GND	5.5 V		±0.1		±1		±1	μA
I _{OZ}	V _O = V _{CC} or GND	5.5 V		±0.25		±5		±2.5	μA
I _{CC}	V _I = V _{CC} or GND, I _O = 0	5.5 V		4		80		40	μA
C _i	V _I = V _{CC} or GND	5 V		4.5					pF

4.5 Timing Requirements, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$

over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

	·	T _A = 2	T _A = 25°C SN54A0		374	SN74AC374		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
f _{clock}	Clock frequency		60		60		60	MHz
t _w	Pulse duration, CLK high or low	5.5		6.5		6		ns
t _{su}	Setup time, data before CLK↑	5.5		6.5		6		ns
t _h	Hold time, data after CLK↑	1		1		1		ns

4.6 Timing Requirements, $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

		T _A = 2	T _A = 25°C		374	SN74AC374		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	UNII
f _{clock}	Clock frequency		100		95		100	MHz
t _w	Pulse duration, CLK high or low	4		5		4.5		ns
t _{su}	Setup time, data before CLK↑	4		5		4.5		ns
t _h	Hold time, data after CLK↑	1.5		1.5		1.5		ns

4.7 Switching Characteristics, V_{CC} = 3.3 V ± 0.3 V

over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	TO (INPUT)	TO (OUTPUT)	T _A = 25°C			SN54AC374		SN74AC374		UNIT
PARAMETER			MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
f _{max}			60	110		60		60		MHz
t _{PLH}	CLK	Q	3	11	13.5	3	16.5	1.5	15.5	no
t _{PHL}	CLK	Q	2.5	10	12.5	3	15	2	14	ns
t _{PZH}	ŌĒ	Q	3	9.5	11.5	1	14	1.5	13	no
t _{PZL}	OE		3.5	9	11.5	1	14	1.5	13	ns
t _{PHZ}	ŌĒ	OF 0	3	10.5	12.5	1	16	2	14.5	ne
t _{PLZ}	OE	Q	2	8	11.5	1	13	1	12.5	ns

4.8 Switching Characteristics, $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	TO (INPUT)	TO (OUTPUT)	TΔ	T _A = 25°C		SN54AC374		SN74AC374		UNIT
PARAMETER	TO (INPUT)	10 (001701)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
f _{max}			100	155		95		100		MHz
t _{PLH}	CLK	Q	2.5	8	9.5	3	12	1.5	10.5	no
t _{PHL}	CLK	Q	2	7	9	3	11	1.5	10	ns
t _{PZH}	ŌĒ	Q	2	7	8.5	1.5	10	1	9.5	ns
t _{PZL}	OE		2	6.5	8.5	1.5	10.5	1	9.5	115
t _{PHZ}	ŌĒ	0	2	8	11	1.5	12.5	2	12.5	no
t _{PLZ}	OE	Q	1.5	6.5	8.5	1.5	10.5	1	10	ns

4.9 Operating Characteristics

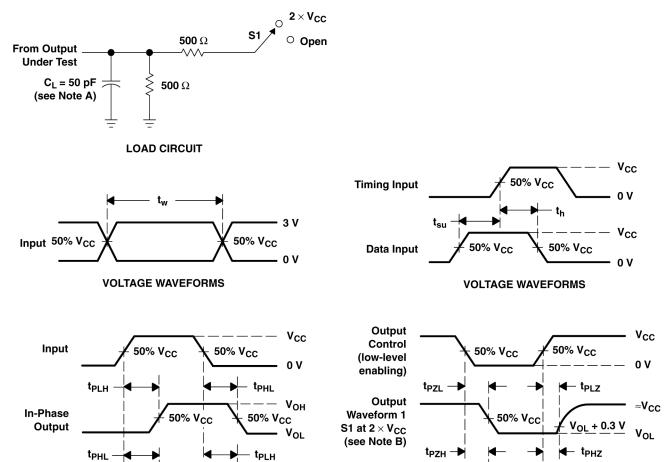
 V_{CC} = 5 V, T_A = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	$C_L = 50 \text{ pF}, \qquad f = 1 \text{ MHz}$	40	pF

Product Folder Links: SN54AC374 SN74AC374



5 Parameter Measurement Information



VOLTAGE WAVEFORMS

50% V_{CC}

VOLTAGE WAVEFORMS

50% V_{CC}

V_{OH} - 0.3 V

≈0 V

A. C_L includes probe and jig capacitance.

Out-of-Phase

Output

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

Output

Waveform 2

S1 at Open

(see Note B)

C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_r \leq 2.5$ ns. $t_f \leq 2.5$ ns.

 v_{OH}

 V_{OL}

50% V_{CC}

D. The outputs are measured one at a time with one input transition per measurement.

Figure 5-1. Load Circuit and Voltage Waveforms

TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	2 × V _{CC}
t _{PHZ} /t _{PZH}	Open

6 Detailed Description

6.1 Overview

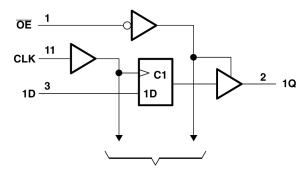
The eight flip-flops of the 'AC374 devices are D-type edge-triggered flip-flops. On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and the increased drive provide the capability to drive bus lines in bus-organized systems without need for interface or pullup components.

OE does not affect internal operations of the flip-flop. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

For specified high-impedance state during power up or power down, \overline{OE} must be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

6.2 Functional Block Diagram



To Seven Other Channels

Figure 6-1. Logic Diagram (Positive Logic)

6.3 Device Functional Modes

Table 6-1. Function Table (Each Flip-flop)

	INPUTS	OUTPUT Q	
OE	CLK		
L	1	Н	Н
L	1	L	L
L	H or L	Х	Q ₀
Н	X	Х	Z



7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Power Supply Recommendations

The power supply can be any voltage between the min and max supply voltage rating located in Section 4.2.

Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends 0.1 μ F and if there are multiple V_{CC} terminals, then TI recommends .01 μ F or .022 μ F for each power terminal. It is okay to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

7.2 Layout

7.2.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float. In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only three of the four buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified below are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} whichever make more sense or is more convenient. Floating outputs is generally acceptable, unless the part is a transceiver. If the transceiver has an output enable pin it will disable the outputs section of the part when asserted. This will not disable the input section of the I.O's so they also cannot float when disabled.

7.2.1.1 Layout Example

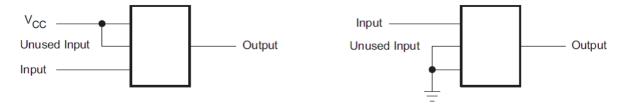


Figure 7-1. Layout Example



8 Device and Documentation Support

8.1 Documentation Support (Analog)

8.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 8-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN54AC374	Click here	Click here	Click here	Click here	Click here	
SN74AC374	Click here	Click here	Click here	Click here	Click here	

8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on Notifications to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

8.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

8.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

8.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision F (August 2023) to Revision G (February 2024) Added Application and Implementation section......9 Changes from Revision E (October 2003) to Revision F (August 2023) Page Added Device Information table, Pin Functions table, Thermal Information table, Device Functional Modes, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information

section1

Product Folder Links: SN54AC374 SN74AC374



10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-87694012A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 87694012A SNJ54AC 374FK	Samples
5962-8769401RA	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8769401RA SNJ54AC374J	Samples
5962-8769401SA	ACTIVE	CFP	W	20	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8769401SA SNJ54AC374W	Samples
SN74AC374DBR	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC374	Samples
SN74AC374DW	OBSOLETE	SOIC	DW	20		TBD	Call TI	Call TI	-40 to 85	AC374	
SN74AC374DWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC374	Samples
SN74AC374N	ACTIVE	PDIP	N	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74AC374N	Samples
SN74AC374NSR	ACTIVE	SOP	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC374	Samples
SN74AC374PW	OBSOLETE	TSSOP	PW	20		TBD	Call TI	Call TI	-40 to 85	AC374	
SN74AC374PWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AC374	Samples
SNJ54AC374FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 87694012A SNJ54AC 374FK	Samples
SNJ54AC374J	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8769401RA SNJ54AC374J	Samples
SNJ54AC374W	ACTIVE	CFP	W	20	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8769401SA SNJ54AC374W	Samples

(1) The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available. **OBSOLETE:** TI has discontinued the production of the device.

PACKAGE OPTION ADDENDUM

www.ti.com 2-Dec-2024

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

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OTHER QUALIFIED VERSIONS OF SN54AC374, SN74AC374:

Catalog: SN74AC374

Military: SN54AC374

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

www.ti.com 7-Dec-2024

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AC374DBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74AC374DWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74AC374DWR	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
SN74AC374NSR	SOP	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74AC374PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1



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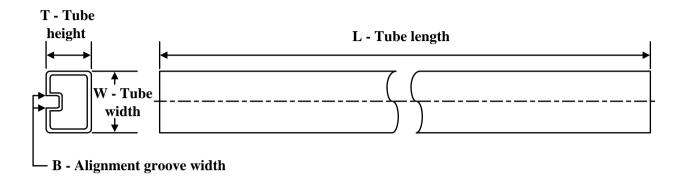
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AC374DBR	SSOP	DB	20	2000	356.0	356.0	35.0
SN74AC374DWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74AC374DWR	SOIC	DW	20	2000	356.0	356.0	45.0
SN74AC374NSR	SOP	NS	20	2000	367.0	367.0	45.0
SN74AC374PWR	TSSOP	PW	20	2000	356.0	356.0	35.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-87694012A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-8769401SA	W	CFP	20	25	506.98	26.16	6220	NA
SN74AC374N	N	PDIP	20	20	506	13.97	11230	4.32
SNJ54AC374FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54AC374W	W	CFP	20	25	506.98	26.16	6220	NA

W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.

 D. Index point is provided on cap for terminal identification only.

 E. Falls within Mil—Std 1835 GDFP2—F20







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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